Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/790,104	CHENG, DIDO
Examiner	Art Unit
David J. Walczak	3751

	SEARCHED				
Class	Subclass	Date	Examiner		
401	52, 195	7/30/2005	DW		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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(INCLUDING SEARCH STRATEGY)		
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